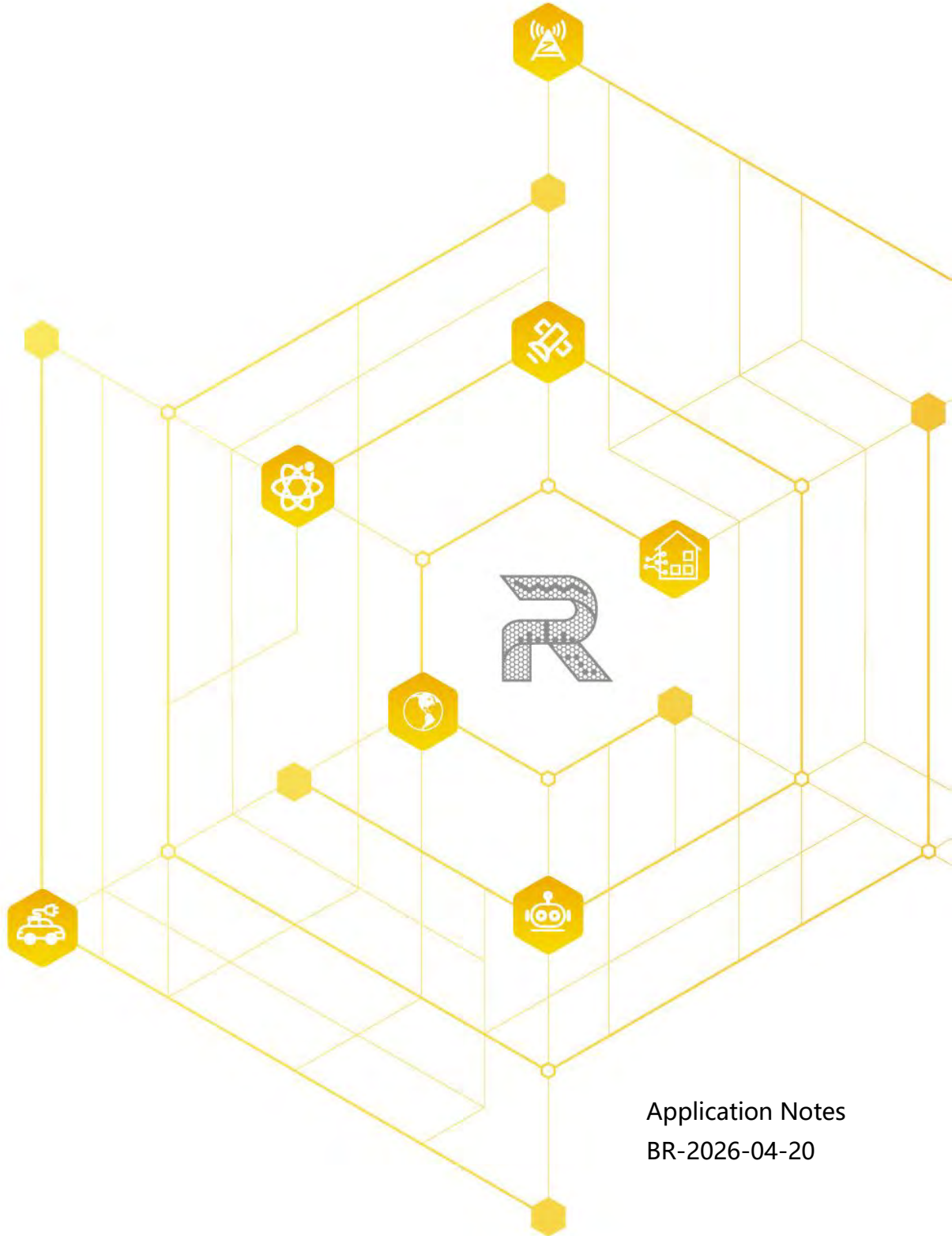




Vector Network Analyzer in in MRI RF Subsystem R&D Testing



Application Notes
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Introduction

Magnetic Resonance Imaging (MRI) is advancing along two parallel paths. High-field systems are pushing toward 7T and beyond to achieve higher resolution, while low-field permanent-magnet technologies are enabling portable MRI systems for use in emergency departments, ICUs, and primary care settings. Together, these trends are expanding both the performance and accessibility of MRI.

MRI image quality fundamentally depends on RF signal integrity. The accuracy of RF excitation, the fidelity of received echo signals, and distortion introduced during power amplification all directly impact the final image. These key performance indicators must be quantified and optimized through systematic RF subsystem testing.

As a result, establishing accurate and repeatable RF measurement capabilities is essential for improving MRI performance and ensuring system consistency.

From Nuclear Spin to Image: RF Requirements in MRI

MRI generates images by exploiting the resonance of hydrogen protons (^1H) in a strong magnetic field. The process consists of four main steps:

1. **Magnetization equilibrium:** A static magnetic field (B_0), typically ranging from 0.2 T to 7 T, aligns proton spins and creates a net magnetization vector.
2. **RF excitation:** RF pulses at the Larmor frequency tip the magnetization away from equilibrium. The Larmor frequency is given by $f = 42.58 \text{ MHz/T} \times B_0$

(e.g., 63.87 MHz at 1.5 T, 127.74 MHz at 3 T)

3. **Signal reception:** As protons relax, they emit weak RF signals (echoes), which are captured by receive coils. These signals contain information about tissue structure and composition.
4. **Spatial encoding and imaging:** Gradient fields enable spatial encoding. After digitization (ADC), the system reconstructs cross-sectional images.

MRI RF Signal Chain

The RF subsystem forms a closed transmit–receive loop:

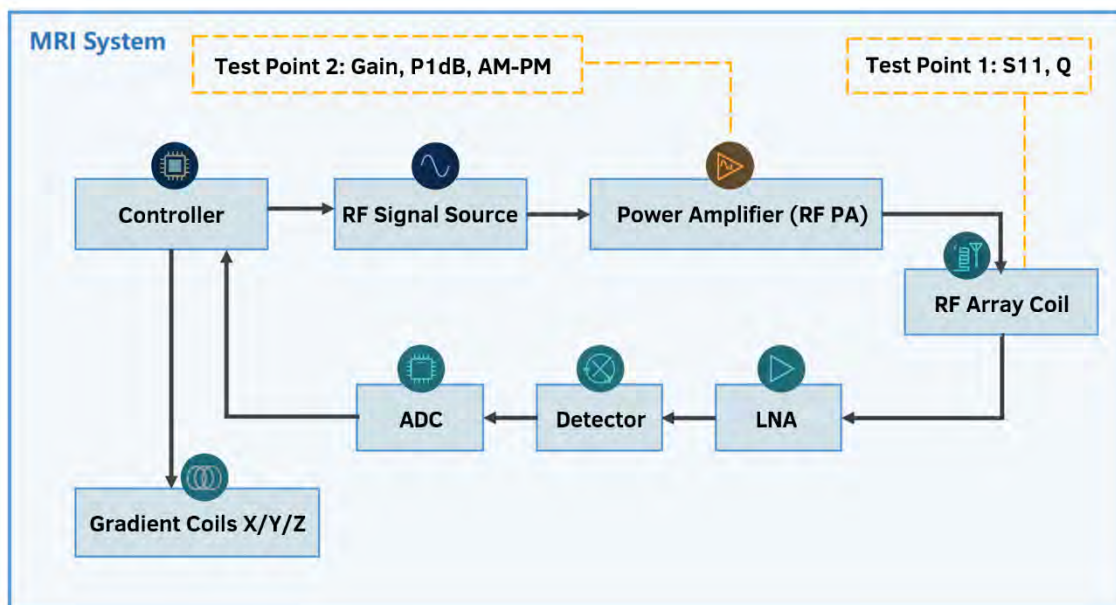
Transmit (TX) Chain:

Control system → RF source → RF power amplifier (PA) → Transmit coil (TX coil) → Tissue

Receive (RX) Chain:

Tissue → Receive coil (RX coil) → Low-noise amplifier (LNA) → Receiver → ADC → Image reconstruction

Within this chain, the RF coil and RF power amplifiers are the most critical components requiring precise RF characterization, as their performance largely determines image quality.



MRI RF architecture and test focus

Application context: R&D test of the MRI RF subsystem

RF subsystem R&D centers on two devices: RF coils and RF power amplifiers. Because both tie directly to image quality, design iterations must be guided by precision RF measurements.

RF coils — transmit/receive “antennas”

Coils directly interact with the patient. Transmit coils deliver RF energy into tissue, while receive coils capture weak NMR signals. Key parameters include resonant frequency, impedance matching, and quality factor (Q), all of which must be optimized at the target Larmor frequency.

RF power amplifiers — the RF “engine”

The PA amplifies low-level RF signals to drive the transmit coil. MRI systems impose strict linearity requirements—nonlinear behavior can introduce flip-angle errors, contrast distortion, and imaging artifacts.

A vector network analyzer (VNA) is the primary instrument used to characterize these components, enabling measurement of S-parameters, impedance, Q, P1dB, and AM-to-PM conversion.

Key Challenges in MRI RF Testing

1 Precise resonance at the Larmor frequency

Coils must resonate exactly at the target frequency (e.g., 127.74 MHz at 3 T). Any deviation reduces excitation efficiency and signal-to-noise ratio (SNR). Tuning the matching network is often the most time-consuming part of coil development.

2: Q-factor trade-off

A low Q results in higher losses and reduced SNR, while an excessively high Q narrows bandwidth and may not support broadband pulse sequences (e.g., EPI). Both unloaded and loaded Q must be measured to balance efficiency and bandwidth.

3: Need for vector measurements in PA analysis

AM-to-PM conversion (phase variation due to amplitude changes) can distort RF pulse phase and introduce imaging artifacts. Scalar instruments cannot capture this effect.

4: Slow traditional PA testing methods

Conventional setups using a signal generator and spectrum analyzer require point-by-point measurements, often taking tens of minutes—too slow for iterative R&D.

Test Metric	Related Component	If Testing is Inadequate
Resonant frequency / S11	RF coil	Resonance drifts from Larmor frequency → lower excitation efficiency → SNR loss, blurred images
Quality factor Q	RF coil	Q deviates from target → energy efficiency vs. bandwidth out of balance → poor SNR or limited imaging speed
Gain / P1dB	Power amplifier	Insufficient gain or operation in compression → flip-angle error → tissue contrast distortion
AM-PM conversion	Power amplifier	Amplitude-driven phase modulation → distorted RF pulse phase → image artifacts

RIGOL Solution: VNA-Based Measurement Approach

RIGOL DNA5000/6000 series VNAs provides a comprehensive and efficient solution to these challenges.

Addressing challenge 1: Resonance and Impedance (S11 + Smith Chart)

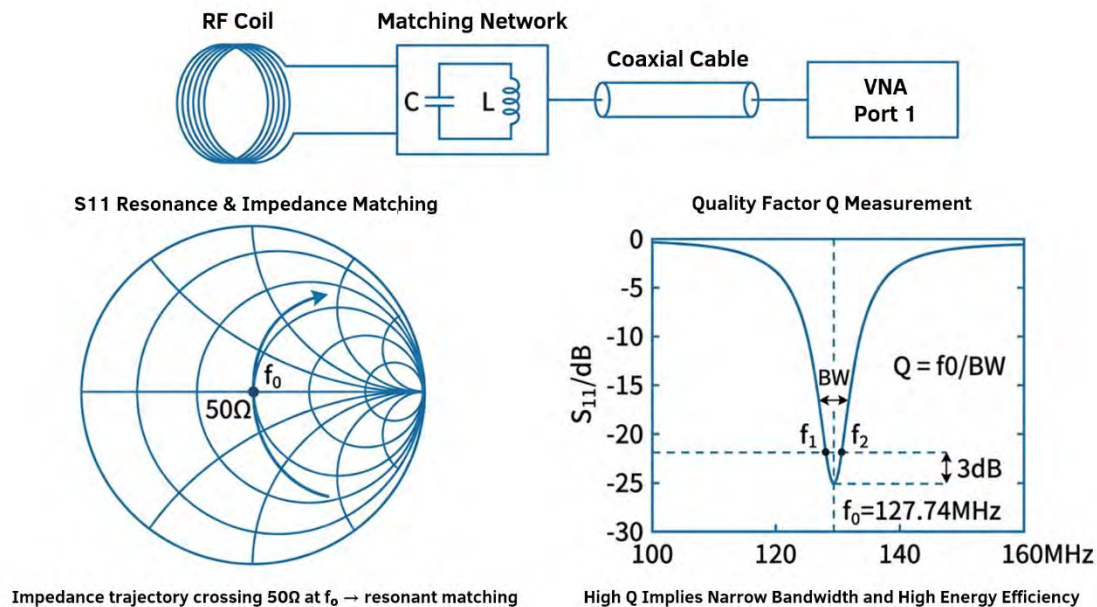
S11 measurements identify the resonant frequency and matching quality. A return loss better than -15 dB ($\approx 3\%$ reflected power) is typically desired. The Smith chart enables intuitive visualization of impedance versus frequency, allowing systematic tuning instead of trial-and-error adjustments.

Addressing challenge 2: Q Measurement via Bandwidth Analysis

The -3 dB bandwidth method determines Q using:

$$Q = f_0 / BW_{-3dB}$$

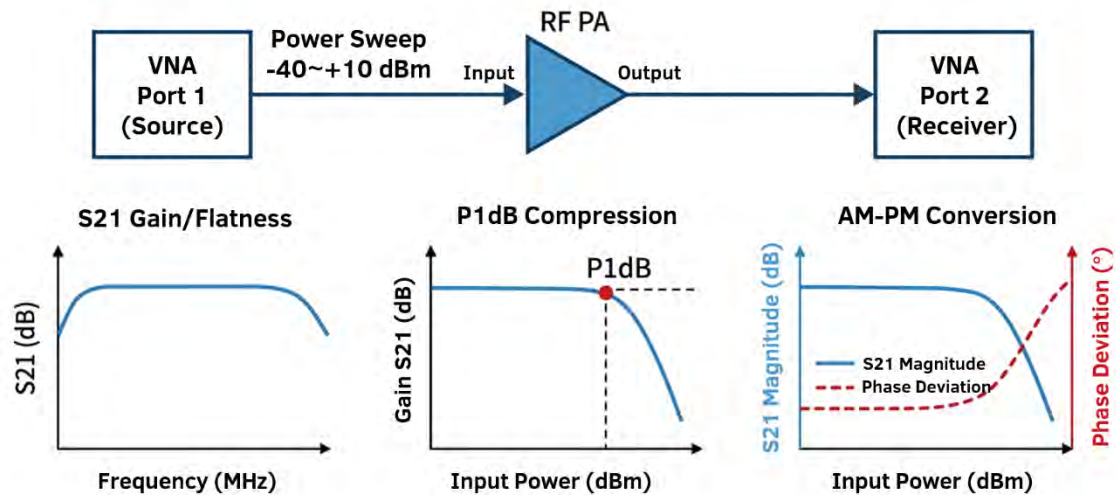
Both unloaded and loaded Q can be measured, with their ratio indicating coupling efficiency.



Addressing challenges 3 & 4: Fast PA Characterization (Power Sweep)

DNA5000/6000 VNAs support power sweeps from -40 dBm to $+10$ dBm, capturing S_{21} magnitude and phase vs. drive in a single sweep so P1dB and AM-to-PM are obtained together:

1. Calibration: Perform full two-port calibration (SOLT or ECal) at the PA input and output.
2. Frequency sweep: Measure gain flatness (S_{21}), input/output match (S_{11}/S_{22}), and isolation (S_{12}) in the linear region.
3. Power sweep: At the Larmor frequency, sweep input power and record: Gain compression (P1dB), Phase variation (AM-to-PM), Measurement time is reduced from minutes to seconds.
4. Harmonic Analysis: A spectrum analyzer (RIGOL RSA6000 Series) can be used to evaluate harmonic emissions for safety and EMC compliance.



Challenge–Solution Overview

R&D Test Challenges	VNA-Based Solution	Key Capabilities
C1 Precise locking of coil	S_{11} + Smith chart	Impedance trajectory visualization; directional tuning of the matching network
C2 Q-factor trade-offs	Automatic bandwidth-search measurement	Accurate unloaded vs. loaded Q; data-driven design trade-offs
C3 PA AM-PM needs phase	Vector power sweep	Simultaneous magnitude and phase-not replaceable by scalar-only instruments
C4 Low efficiency of conventional PA testing	Built-in VNA power sweep	Typical run time from tens of minutes to tens of seconds-large efficiency gain

Field Results

In practical deployment, MRI system developers have reported:

- P1dB test time reduced from over 20 minutes to ~30 seconds
- Simultaneous acquisition of AM-to-PM data
- Significant reduction in coil tuning time using Smith chart and bandwidth tools
- Automated test workflows enabled via SCPI control

Conclusion

MRI RF R&D pushes RF performance in a very narrow frequency window: coils must couple optimally at the exact Larmor frequency, and PAs must stay linear at high output. Because only a VNA returns magnitude and phase together, it is indispensable in this workflow.

RIGOL DNA5000/6000 VNAs combine high dynamic range, wide power sweeps, and rich analysis to underpin dependable R&D measurements for MRI RF hardware.

RIGOL DNA5000/6000 Series Vector Network Analyzer Highlights

- **Frequency: 5 kHz to 26.5 GHz**
- **System dynamic range: up to 127 dB**
- **Trace noise: as low as 0.003 dB rms**
- **Power sweep range: -40 to +10 dBm**
- **Smith chart, bandwidth search, group delay, and more**
- **SCPI programming and Web Control remote access**

Boost Smart World and Technology Innovation

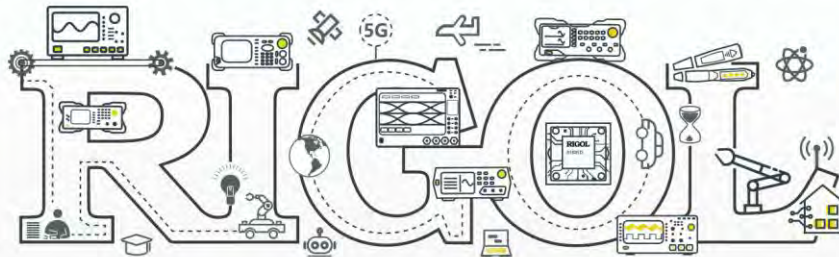
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